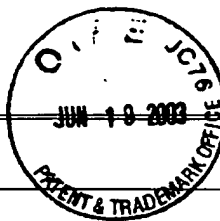


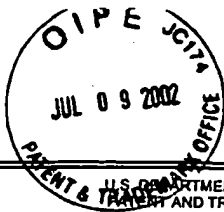
Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 220400US0X		SERIAL NO. 10/091,315	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Seisaku KUMAI, et al.			
				FILING DATE March 6, 2002		GROUP 1714	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
ce	AO	2000-86809	03/28/2000	JAPAN (with English Abstract)			
	AP	11-288732	10/19/99	JAPAN (with English Abstract)			
ce	AQ	03-014860	02/27/91	JAPAN (with English Abstract)			
	AR						
	AS						
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	AU						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AV						
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Examiner <i>Orlch</i>					Date Considered 2/04		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Seisaku KUMAI, et al.		GROUP 1714	
				FILING DATE March 6, 2002			
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
RC	AA	6,515,102	02/04/03	KUMAI, et al.			
	AB						
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					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner <i>Chell</i>					Date Considered <i>2/05</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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ATTY DOCKET NO.

220400US0X

SERIAL NO.

10/091,315

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Seisaku KUMAI, et al.

FILING DATE

March 6, 2002

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1714

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
EC	AA	4,585,801	04/29/86	H. S. BURNEY, JR., et al.			
DC	AB	4,433,082	02/21/84	W. G. GROT			
	AC						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
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	AQ				
	AR				
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	AU				
	AV				

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

EC	AW	Patent Abstracts of Japan, JP 2000 086809, March 28, 2000
	AX	
	AY	
	AZ	

Examiner

Date Considered

2/3

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